



Low Loss IGBT: IGBT in TRENCHSTOP™ and Fieldstop technology



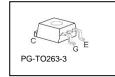




Features:

- Very low V_{CE(sat)} 1.5V (typ.)
- Maximum Junction Temperature 175°C
- Short circuit withstand time 5μs
- Designed for frequency inverters for washing machines, fans, pumps and vacuum cleaners
- TRENCHSTOP™ technology for 600V applications offers :
 - very tight parameter distribution
 - high ruggedness, temperature stable behavior
 - very high switching speed
- Positive temperature coefficient in $V_{CE(sat)}$
- Low EMI
- Low Gate Charge
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC¹ for target applications
- Complete product spectrum and PSpice Models : http://www.infineon.com/igbt/





Туре	V_{CE}	I _C	V _{CE(sat),Tj=25°C}	$T_{\rm j,max}$	Marking	Package
IGB50N60T	600 V	50 A	1.5 V	175 °C	G50T60	PG-TO263-3

Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage, <i>T</i> _j ≥ 25°C	V _{CE}	600	V
DC collector current, limited by T_{jmax}			
$T_{\rm C}$ = 25°C, value limited by bondwire	Ic	90	
$T_{\rm C}$ = 100°C		64	Α
Pulsed collector current, t_p limited by T_{jmax}	I _{Cpuls}	150	
Turn off safe operating area, $V_{CE} = 600 \text{V}$, $T_j = 175 ^{\circ}\text{C}$, $t_p = 1 \mu\text{s}$	-	150	
Gate-emitter voltage	V _{GE}	±20	V
Short circuit withstand time ²⁾	1	5	
$V_{\rm GE}$ = 15V, $V_{\rm CC} \le 400$ V, $T_{\rm j} \le 150$ °C	t_{SC}	5	μS
Power dissipation $T_C = 25^{\circ}C$	P _{tot}	333	W
Operating junction temperature	T _j	-40+175	
Storage temperature	$T_{\rm stg}$	-55+150	°C
Soldering temperature (reflow soldering, MSL1)	-	260	

IFAG IPC TD VLS 1 Rev. 2.7 19.05.2015

¹ J-STD-020 and JESD-022

²⁾ Allowed number of short circuits: <1000; time between short circuits: >1s.



IGB50N60T

TRENCHSTOP™ Series

Thermal Resistance

Parameter	Symbol	Conditions	Max. Value	Unit
Characteristic				
IGBT thermal resistance,	R _{thJC}		0.45	K/W
junction – case				
Thermal resistance,	R_{thJA}	6cm² Cu	40	
junction – ambient				

Electrical Characteristic, at $T_j = 25$ °C, unless otherwise specified

Parameter	Cumbal	Conditions	Value			Unit
raiailletei	Symbol	Conditions	min.	Тур.	max.	Oilit
Static Characteristic						
Collector-emitter breakdown voltage	$V_{(BR)CES}$	$V_{\rm GE} = 0 \text{V}, I_{\rm C} = 0.2 \text{mA}$	600	-	-	V
Collector-emitter saturation voltage	V _{CE(sat)}	$V_{\rm GE} = 15 \rm V, \ I_{\rm C} = 50 \rm A$				
		<i>T</i> _j =25°C	-	1.5	2.0	
		<i>T</i> _j =175°C	-	1.9	-	
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_{\rm C}$ =0.8mA, $V_{\rm CE}$ = $V_{\rm GE}$	4.1	4.9	5.7	
Zero gate voltage collector current	I _{CES}	V _{CE} =600V, V _{GE} =0V				μA
		<i>T</i> _j =25°C	-	-	40	
		<i>T</i> _j =175°C	-	-	3500	
Gate-emitter leakage current	I _{GES}	$V_{\text{CE}}=0\text{V}, V_{\text{GE}}=20\text{V}$	-	-	100	nA
Transconductance	g_{fs}	$V_{CE} = 20V, I_{C} = 50A$	-	31	-	S
Integrated gate resistor	R _{Gint}			-		Ω

Dynamic Characteristic

Input capacitance	Ciss	V _{CE} =25V,	-	3140	-	pF
Output capacitance	Coss	$V_{GE}=0V$,	1	200	-	
Reverse transfer capacitance	Crss	f=1MHz	-	93	-	
Gate charge	Q _{Gate}	$V_{\rm CC} = 480 \text{V}, I_{\rm C} = 50 \text{A}$	-	310	-	nC
		V _{GE} =15V				
Internal emitter inductance	LE		-	7	-	nΗ
measured 5mm (0.197 in.) from case						
Short circuit collector current ¹⁾	$I_{C(SC)}$	$V_{\text{GE}} = 15 \text{V}, t_{\text{SC}} \le 5 \mu \text{s}$ $V_{\text{CC}} = 400 \text{V},$ $T_{\text{j}} \le 150 ^{\circ} \text{C}$	-	458.3	-	A

¹⁾ Allowed number of short circuits: <1000; time between short circuits: >1s.



IGB50N60T

TRENCHSTOP™ Series

Switching Characteristic, Inductive Load, at T_j =25 °C

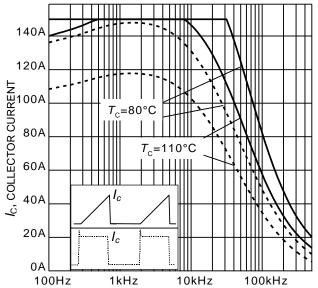
Dovementor	Crombal	Canditions	Value			111:4
Parameter	Symbol	Conditions	min.	Тур.	max.	Unit
IGBT Characteristic						
Turn-on delay time	$t_{d(on)}$	$T_{\rm j} = 25^{\circ} \rm C$,	-	26	-	ns
Rise time	t _r	$\dot{V_{CC}}$ =400V, I_{C} =50A, V_{GE} =0/15V, I_{C} =7 Ω , L_{σ} =103nH, L_{σ} =39pF L_{σ} , L_{σ} from Fig. E Energy losses include "tail" and diode reverse	-	29	-	
Turn-off delay time	$t_{d(off)}$		-	299	-	
Fall time	t_{f}		-	29	-	
Turn-on energy	Eon		-	1.2	-	mJ
Turn-off energy	E _{off}	recovery.	-	1.4	-	
Total switching energy	Ets	Diode from IKW50N60T	-	2.6	-	

Switching Characteristic, Inductive Load, at T_i =150 °C

Doromotor	Combal	Conditions	Value			l lm!4
Parameter	Symbol	Conditions	min.	Тур.	max.	Unit
IGBT Characteristic	•					
Turn-on delay time	t _{d(on)}	T _j =175°C,	-	27	-	ns
Rise time	t _r	$V_{\rm CC}$ =400V, $I_{\rm C}$ =50A, $V_{\rm GE}$ =0/15V, $I_{\rm G}$ =7 Ω , L_{σ} =103nH, C_{σ} =39pF L_{σ} , C_{σ} from Fig. E Energy losses include "tail" and diode reverse	-	33	-	
Turn-off delay time	t _{d(off)}		-	341	-	
Fall time	t _f		-	55	-	
Turn-on energy	Eon		-	1.8	-	mJ
Turn-off energy	E _{off}	recovery. Diode from IKW50N60T	-	1.8	-	
Total switching energy	E _{ts}		-	3.6	-	

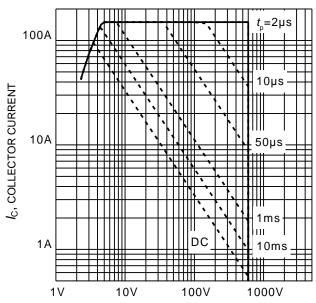






f, SWITCHING FREQUENCY

Figure 1. Collector current as a function of switching frequency $(T_j \le 175^{\circ}\text{C}, D = 0.5, V_{\text{CE}} = 400\text{V}, V_{\text{GE}} = 0/15\text{V}, r_{\text{G}} = 7\Omega)$



 V_{CE} , COLLECTOR-EMITTER VOLTAGE

Figure 2. Safe operating area $(D=0, T_C=25^{\circ}\text{C}, T_j \leq 175^{\circ}\text{C}; V_{\text{GE}}=0/15\text{V})$

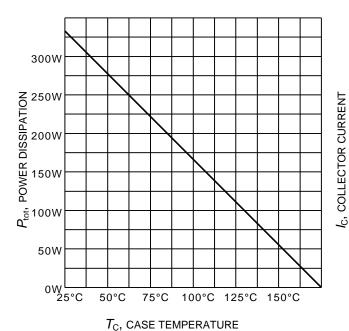
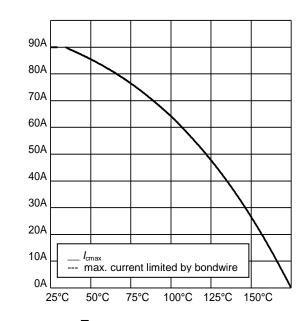


Figure 3. Power dissipation as a function of case temperature $(T_i \le 175^{\circ}\text{C})$



 $T_{\rm C}$, CASE TEMPERATURE

Figure 4. Collector current as a function of case temperature $(V_{GE} \ge 15V, T_j \le 175^{\circ}C)$





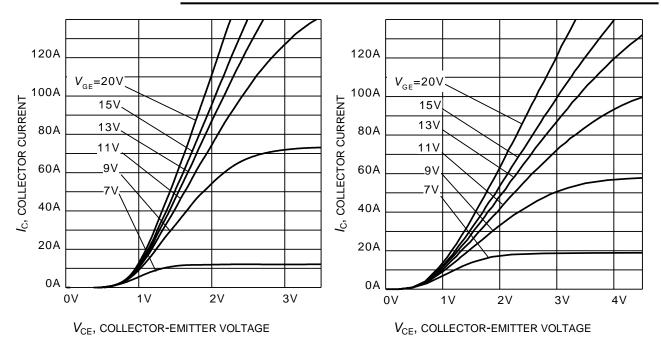


Figure 5. Typical output characteristic $(T_i = 25^{\circ}C)$

Figure 6. Typical output characteristic $(T_i = 175^{\circ}C)$

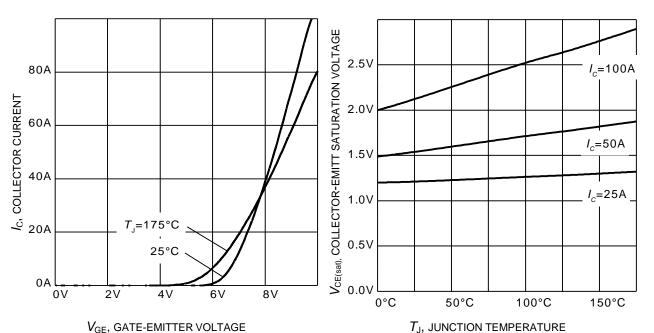
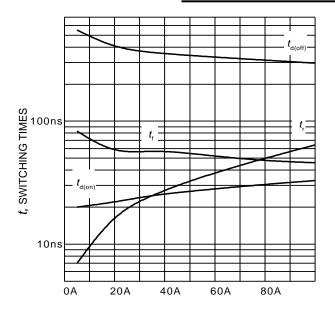


Figure 7. Typical transfer characteristic $(V_{CE}=20V)$

Figure 8. Typical collector-emitter saturation voltage as a function of junction temperature $(V_{GE} = 15V)$







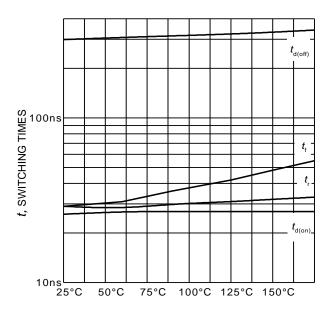
 $t_{d(off)}$ t_{r} t_{r} $t_{d(on)}$ 0Ω 5Ω $100 \text{ } 15\Omega$ 20Ω 25Ω

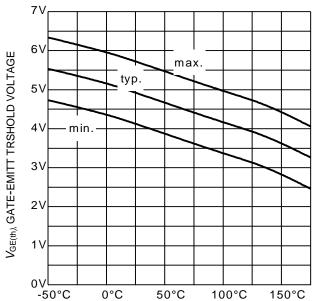
 $I_{\rm C}$, COLLECTOR CURRENT

Figure 9. Typical switching times as a function of collector current (inductive load, T_J =175°C, V_{CE} = 400V, V_{GE} = 0/15V, r_G = 7 Ω , Dynamic test circuit in Figure E)

 $R_{\rm G}$, gate resistor

Figure 10. Typical switching times as a function of gate resistor (inductive load, $T_J = 175$ °C, $V_{CE} = 400$ V, $V_{GE} = 0/15$ V, $I_C = 50$ A, Dynamic test circuit in Figure E)





 $T_{\rm J}$, JUNCTION TEMPERATURE

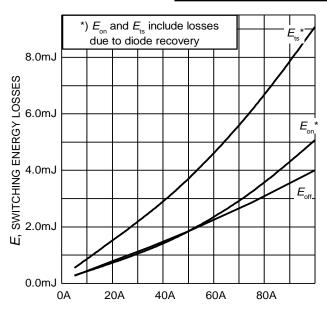
Figure 11. Typical switching times as a function of junction temperature (inductive load, $V_{\rm CE}$ = 400V, $V_{\rm GE}$ = 0/15V, $I_{\rm C}$ = 50A, $r_{\rm G}$ =7 Ω , Dynamic test circuit in Figure E)

 $T_{\rm J}$, JUNCTION TEMPERATURE

Figure 12. Gate-emitter threshold voltage as a function of junction temperature $(I_C = 0.8 \text{mA})$







) $E_{\rm on}$ and $E_{\rm ts}$ include losses due to diode recovery $E_{\rm ts}^$ 5.0mJ

4.0mJ

3.0mJ $E_{\rm on}^*$ 1.0mJ $E_{\rm on}^*$ 0.0mJ

20 Ω

 $I_{\rm C}$, COLLECTOR CURRENT

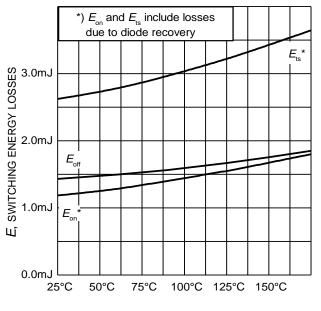
Figure 13. Typical switching energy losses as a function of collector current

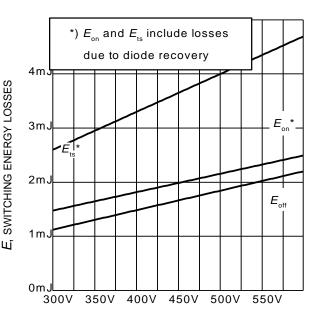
(inductive load, $T_J = 175$ °C, $V_{CE} = 400$ V, $V_{GE} = 0/15$ V, $r_G = 7\Omega$, Dynamic test circuit in Figure E)

 $R_{\rm G}$, gate resistor

Figure 14. Typical switching energy losses as a function of gate resistor

(inductive load, $T_J = 175$ °C, $V_{CE} = 400$ V, $V_{GE} = 0/15$ V, $I_C = 50$ A, Dynamic test circuit in Figure E)





 $T_{
m J}$, JUNCTION TEMPERATURE

Figure 15. Typical switching energy losses as a function of junction temperature

(inductive load, $V_{\rm CE}$ = 400V, $V_{\rm GE}$ = 0/15V, $I_{\rm C}$ = 50A, $r_{\rm G}$ = 7 Ω , Dynamic test circuit in Figure E) V_{CE} , COLLECTOR-EMITTER VOLTAGE

Figure 16. Typical switching energy losses as a function of collector emitter voltage

(inductive load, T_J = 175°C, V_{GE} = 0/15V, I_C = 50A, r_G = 7 Ω , Dynamic test circuit in Figure E)





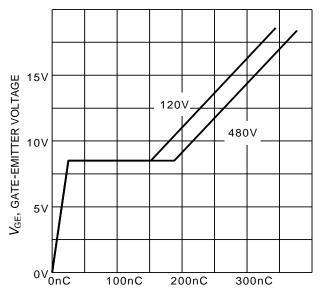
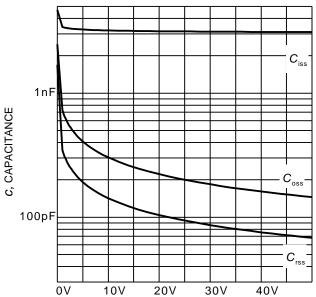


Figure 17. Typical gate charge

 $(I_{\rm C} = 50 \text{ A})$

 Q_{GE} , GATE CHARGE



 $V_{\rm CE}$, COLLECTOR-EMITTER VOLTAGE

Figure 18. Typical capacitance as a function of collector-emitter voltage $(V_{GE}=0V, f=1 \text{ MHz})$

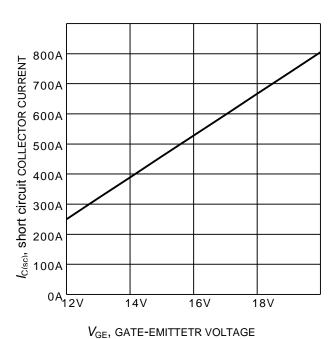
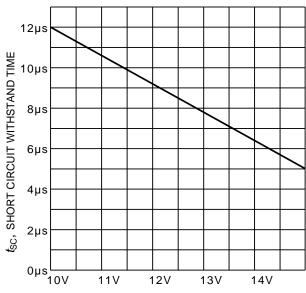


Figure 19. Typical short circuit collector current as a function of gateemitter voltage

 $(V_{CE} \le 400 \text{V}, T_i \le 150^{\circ}\text{C})$



 $V_{\rm GE}$, gate-emitetr voltage

Figure 20. Short circuit withstand time as a function of gate-emitter voltage (V_{CE} =400V, start at T_{J} =25°C, T_{Jmax} <150°C)





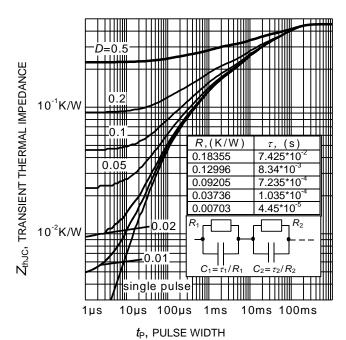
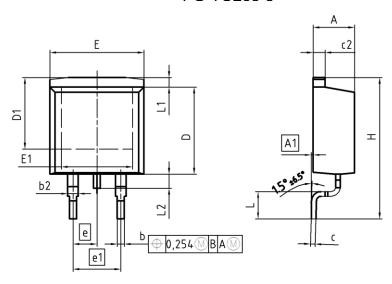
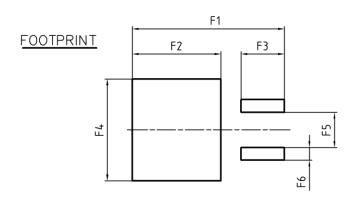


Figure 21. IGBT transient thermal impedance $(D = t_p / T)$



PG-TO263-3



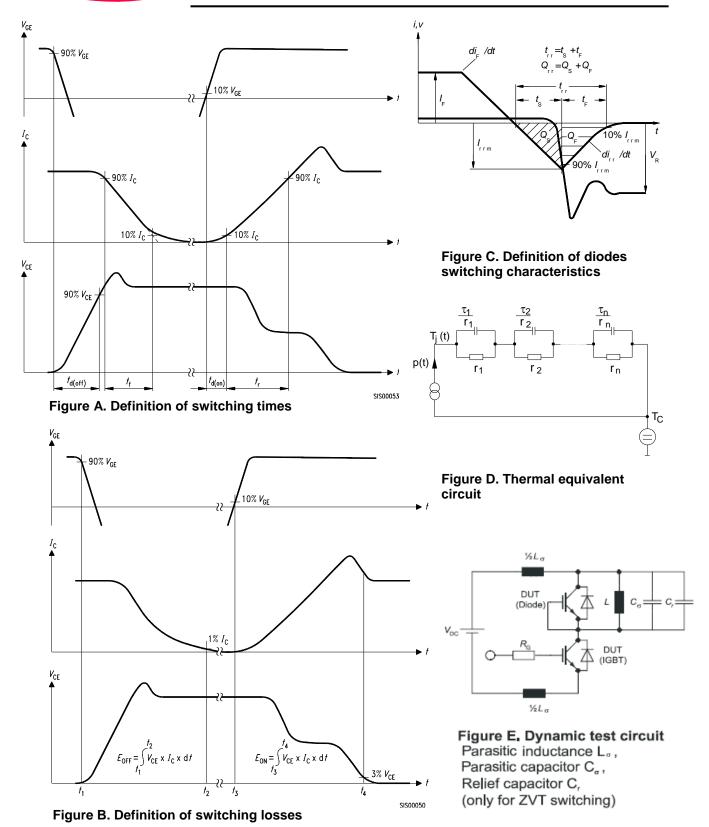


DIM	MILLIMI	MILLIMETERS		HES		
DIM	MIN	MAX	MIN	MAX		
Α	4.30	4.57	0.169	0.180		
A1	0.00	0.25	0.000	0.010		
b	0.65	0.85	0.026	0.033		
b2	0.95	1.15	0.037	0.045		
С	0.33	0.65	0.013	0.026		
c2	1.17	1.40	0.046	0.055		
D	8.51	9.45	0.335	0.372		
D1	7.10	7.90	0.280	0.311		
E	9.80	10.31	0.386	0.406		
E1	6.50	8.60	0.256	0.339		
е	2.5	54	0.1	0.100		
e1	5.0	8	0.2	200		
N	:	2	2	2		
Н	14.61	15.88	0.575	0.625		
L	2.29	3.00	0.090	0.118		
L1	0.70	1.60	0.028	0.063		
L2	1.00	1.78	0.039	0.070		
F1	16.05	16.25	0.632	0.640		
F2	9.30	9.50	0.366	0.374		
F3	4.50	4.70	0.177	0.185		
F4	10.70	10.90	0.421	0.429		
F5	3.65	3.85	0.144	0.152		
F6	1.25	1.45	0.049	0.057		

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0 5 5 – 7.5mm
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REVISION 01











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